



FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

107318-00000

SERIAL NO.

09/813,866

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT

HIRANO et al.

FILING DATE

March 22, 2001

GROUP

2811

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	5,943,593	8/24/1999	Noguchi et al.			
	AB	5,336,641	8/9/1994	Fair et al.			
	AC	4,822,751	4/18/1989	Ishizu et al.			
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART.		
	AG								
	AH								
	AI								
	AJ								
	AK								
	AL								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AM	
	AN	
	AO	

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
107318-00000Sheet 1 of 1
SERIAL NO.
09/673,866APPLICANT
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	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION		
							YES	NO	PART.
Sam	AG	JP 02-194626 A	8/1/1990	Japan					X
Sam	AH	JP 05-53143 A	3/5/1993	Japan					X
Sam	AI	JP 06-260645 A	9/16/1994	Japan					X
	AJ								
	AK								
	AL								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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DATE CONSIDERED

Samuel A. Johnson

10/16/02

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